TestPad 2000TM

2310 SONET Field Services Module



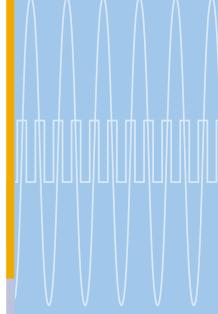
Product Highlights

- Multi-rate transmission testing from DS0 to OC-48c in a single hand-held unit
- Multi-services testing capabilities including ATM, GR-303, ISDN, signaling, voice frequency (VF), and digital data service (DDS)
- Multiple operation modes to terminate and monitor circuits from various network access points
- Easy-to-use, touch-screen graphical user interface (GUI) simplifies and expedites testing
- Modular TestPad 2000 architecture enables up-to-date support for established and emerging technologies in a single platform
- Engineered for the field with rugged construction, lightweight design, and battery-powered operation
- Automated testing features minimize training costs and testing complexity

Application Highlights

- Perform end-to-end BER testing using a wide range of stress test patterns
- Analyze network performance by simulating abnormal conditions and inserting various errors and alarms
- Perform in-service monitoring of the circuit under test to ensure quality of service
- Verify proper provisioning of network multiplexers and de-multiplexers
- Qualify protocol services such as ATM, GR-303, and ISDN and decode protocol messages
- Perform VF and signaling analysis on test circuits
- Troubleshoot performance of channelized DS0 services from an in-service circuit using the drop and insert operational mode
- Perform network timing synchronization tests and isolate timing errors

The 2310 SONET Field Services Module is an all-in-one integrated testing solution that performs multi-rate transmission testing from DS0 to OC-48/48c and supports physical layer and enhanced services testing at different network rates. Its modular architecture protects your long-term investment by providing the flexibility, scalability, and field upgradability to support evolving test needs.





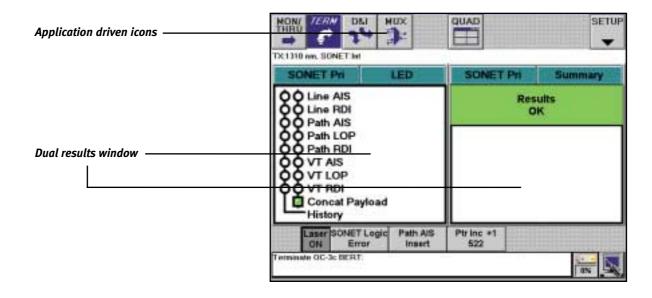
Function Highlights

- Test optical interfaces at OC-48/48c, OC-12/12c, and OC-3/3c rates
- Test electrical interfaces at STS-1, DS3, and DS1 rates
- Perform bit error rate tests on SONET/DS3/DS1 circuits
- Manipulate SONET overhead bytes with an easy-to-use interface and analyze network performance under abnormal conditions
- Perform bi-directional monitoring of STS-1/DS3/DS1 circuits
- Monitor and test ATM circuits and verify quality of service measurements
- Place and receive calls on an ISDN PRI circuit and test non-facility associated signaling (NFAS) and backup D-Channel circuits
- Monitor GR-303 protocol links for proper configuration and collect call statistics
- Analyze signaling bits on a T1 voice trunk and place and receive calls
- Use VT100 emulation to configure and monitor network elements

Features

The 2310 meets the ever-changing needs of today's transmission test workforce with powerful features that provide streamlined, reliable functionality across all applications. With the 2310, testing and service qualification are as easy as the touch of a button. Because technicians need only minimal training to use this equipment, testing objectives are addressed more quickly and costs of ownership are significantly reduced. Key features on the 2310 include:

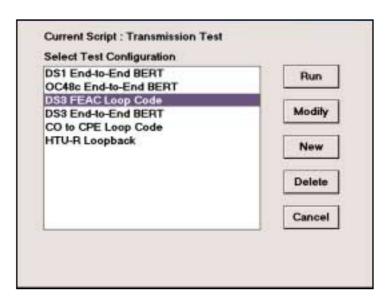
Application-Driven Icons—Test application buttons are labeled with icons which clearly depict the way the test is performed on the circuit (e.g., circuit monitoring tests are indicated by "MON/THRU"). The icons and quick setup buttons enable techicians to use the 2310 effectively, with very little training.



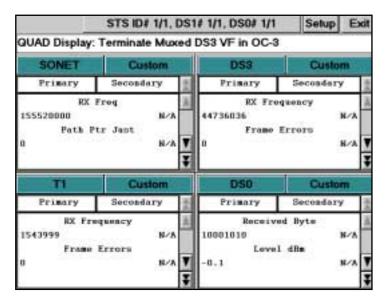
Auto Configuration—Support for auto configuration is provided in all key applications on the 2310. One-button touch configures different test parameters, such as framing, pattern, and tributary scan, and enables users to reduce the test set-up time required.

Automation—Reduce set-up time and increase efficiency of the tests performed by running pre-programmed scripts off the PCMCIA card. The command line remote control feature enables technicians to connect to the 2310 through the PCMCIA serial card or PCMCIA modem and configure tests or analyze results in detail.

Use automation scripts to verify network performance with the touch of a single button



Configurable Results (Quad Results™)—Correlate results from multiple interfaces and payload mappings (SONET/DS3/DS1) and quickly assess network performance by using the 2310's configurable results features. It also provides functionality to analyze selected results simultaneously in up to four windows.



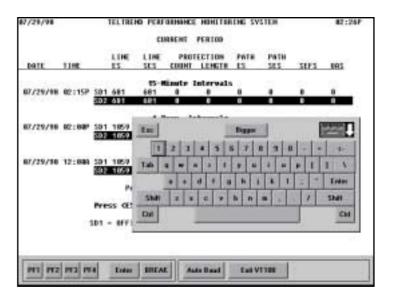
View selected results from multiple interfaces simultaneously

Physical, Active Port, and Laser Active LEDs—A bright array of physical LEDs on the front panel summarizes results and clearly identifies errors detected during a test. Active Port LEDs on the top panel display the interfaces to use for specific tests—a key consideration when performing mux tests. Laser Active LEDs indicate when the transmit laser is active and when laser pulses are received.

Simultaneous Results for Different Signal Rates—Analyze results from different signal rates simultaneously (e.g., DS1 in a muxed DS3 in an OC-3 signal) to quickly identify the source of problems and verify circuit performance. Soft LED results also provide rapid access to information on errors and alarms.

VT100 Emulation—Perform VT100 terminal emulation to connect to network elements in order to perform configurations and monitor available statistics.

Perform VT100 emulation to configure network elements and monitor statistics



Timed Prints and Error Logs—Print results every few minutes, at the end of a test, or at the occurrence of an error using the 2310's print features.

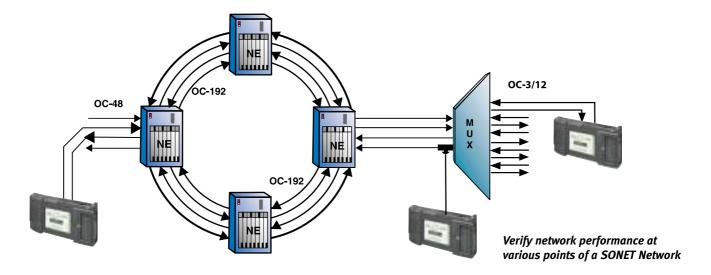
Through Mode for All Rates—Gain access to test circuits (DS1 through OC-48) even when no test access or monitor point is provided. The 2310's Through mode capability monitors test circuits by channeling network traffic through the test equipment.

Applications

SONET Analysis

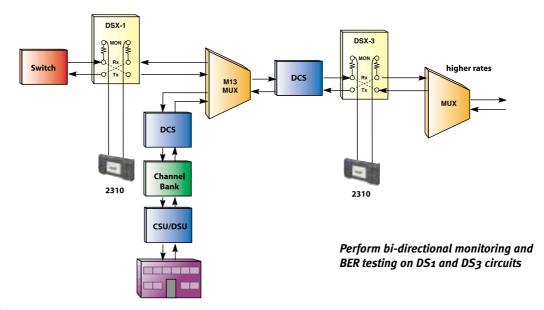
Qualify the performance of SONET networks quickly and easily with the 2310's intuitive GUI. With its support for various payload mappings, the 2310 enables testing and verification of individual payloads inside an OC-n signal (DS1, DS3, muxed DS3, VT1.5, OC-n subrates). Technicians can name and identify trace messages and payloads by using the 2310's user-configurable path trace messages. The 2310's SONET test applications can be used to:

- Verify end-to-end network performance via BER testing at optical and electrical interface rates (OC-48/48c, OC-12/12c, OC-3/3c, STS-1, DS3, DS1)
- Analyze SONET network performance under abnormal conditions by simulating pointer justifications and inserting error and alarm conditions
- Detect performance degradations and alarms and verify protection line connectivity using Monitor/Through mode
- Verify SONET network element performance by manipulating overhead bytes (e.g., pointer adjustments, alarms, K1/K2 bytes)
- Monitor individual DS1 or DS3 payloads and OC-n subrates for analysis
- Verify signal power, signal frequency, and level measurements



DS₃ Analysis

Ensure DS3 network performance by using end-to-end BER testing and by measuring frequency and signal levels on the circuit under test. Technicians can qualify networks for accurate multiplexer operation by performing BER testing on one or all DS1 channels transmitted by a DS3 multiplexer. Access to the DS3 signal is provided from the DS3 interface or a DS3 signal embedded in an STS-1, OC-3, OC-12, or OC-48 circuit. Reduce total testing time on DS3 circuits by using the dual DS3 receivers to perform bi-directional monitoring.



DS1 Analysis

Verify T1 network performance with the 2310's integrated BER test and with signal, alarm, and timing tests. A wide range of stress test patterns combined with bi-directional monitoring enable technicians to identify and sectionalize circuit problems and quickly qualify circuits for service acceptance. Users can perform VF analysis of voice trunks with the 2310's VF levels and tones measurement support. The drop-and-insert test feature qualifies a DS0 channel while the T1 circuit remains in service. The 2310 isolates sources of timing errors by using external bits clock input to identify network synchronization problems. Access to the DS1 signal is provided from the T1 interface or from the DS1 signal embedded in a DS3, STS-1, OC-3, OC-12, or OC-48 circuit.

ATM Analysis

Analyze ATM circuits at OC-3c and OC-12c rates and generate multiple cell-streams to perform key quality of service measurements, cell statistics, and bandwidth utilization. The 2310 also provides support to modify the VPI/VCI, PTI, CLP, and GFC fields of the cell header, and to save up to four transmit profiles.

ATM Search [TTC #1 Test Cells] Prev Next VPI Prev Next VPI/VCI Save VPI/VCI to Rx Profile

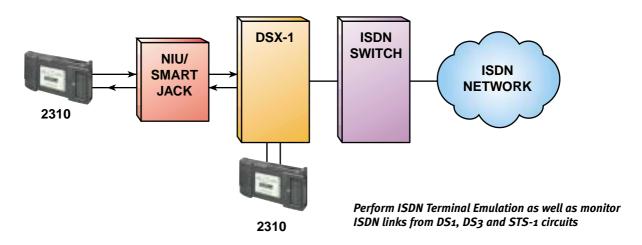
GR-303 Protocol Link Analysis

Perform basic GR-303 protocol link analysis in Monitor/Through mode at the 64K data rate on a call processing (TMC/CSC) or operations channel (EOC). Analysis is conducted unobtrusively to decode messages at the system's protocol links. Technicians can monitor call statistics, filter call control messages based on cause code, or monitor layer-2 packet statistics to qualify proper functioning of the GR-303 interface.

ISDN PRI Testing

Emulate an ISDN TE device (e.g., PBX) to place and receive voice and data calls on an ISDN PRI circuit. The 2310 enables users to monitor and capture signaling messages exchanged on the D-Channel. Call status results and progress reports provide an additional level of detail to ensure calls are successfully established. ISDN functions provided by the 2310 include:

- Support for AT&T—5ESS, DMS-100, National ISDN-II—specific call control
- Backup D-Channel testing functionality to switch between stand-by and in-service D-Channels
- Test multiple DS1 lines with NFAS testing
- Bi-directional monitoring with full text decodes for protocol messages exchanged on the D-Channel



Signaling Analysis

Emulate the PBX/switch for placing and receiving calls and monitor signaling digits for detailed analysis. Key signaling features of the 2310 include:

- Emulate E&M, loop start, and ground start for placing and receiving calls
- DP, DTMF, and MF digit recognition
- · Inter-event or inter-digit delay measurements
- Event and digit duration measurements
- Speaker, microphone, or handset functionality for checking voice integrity
- Signaling (ABCD) bits for all DS0s in one simple result window

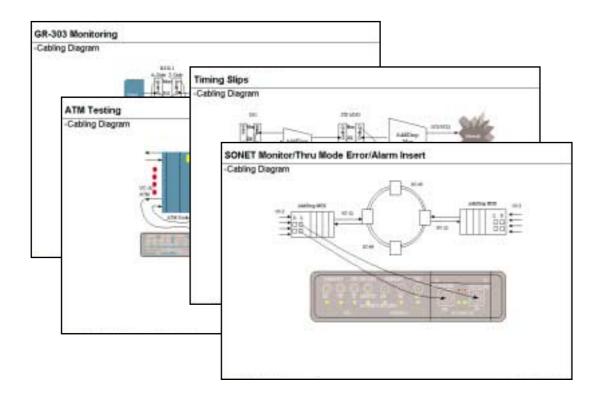
Loop-Back Applications

Sectionalize T1 circuit problems with the 2310's support for NIU/CSU loop-back and user-programmable loop codes. The 2310 verifies proper functioning of Intelligent Line equipment and repeaters using its built-in support to loop-back network equipment. Technicians can also loop-back DS3 circuit network equipment using DS3 FEAC code functionality.

Send Near End Arm						
Arm Disarm						
Loop Up	Loop Down					

Online Help

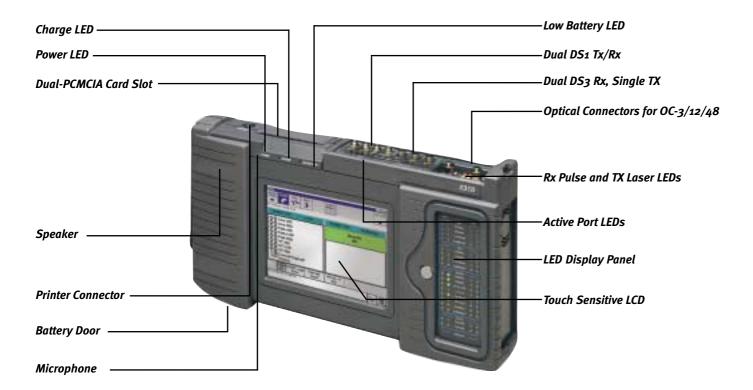
Easy-to-use Help screens provide information on product descriptions; quick cards; screen layouts; cabling diagrams; and contact information.



Online Help provides quick cards and cabling diagrams

Technical Specifications

PHYSICAL CHARACTERISTICS



ENVIRONMENT

Temperature range

Operating	32° F to 113°	F (0° C to 45	°C)
Storage	4° F to 158° F	(-20° C to 70	°C)
Shock and vibration		Meets IEEE-	743

Electrical

Battery type10.8 V Nickel-Metal-Hydride (NiMH)
Operating timeUp to 1.5 hours for performing
DS3/DS1 tests
Recharging period...Maximum 1.5 hours with unit off
AC adaptor19 VDC, 2.6 amps
90-240 VAC, 45-65 Hz

OPTICAL SPECIFICATIONS FOR OC-3/12

Optical connectors

1 OC-3/12 Receive - FC, SC, or ST 1 OC-3/12 Transmit - FC, SC, or ST

Transmit signal

Average output power	er8 dBm to -15 dBm
Eye diagram	Per BELL CORE GR-253-C-1995
Clock frequency acco	uracy± 3 ppm ± 1 ppm per year

Receive signal

Average input power receive level8 dBm to -28 dBm
Frequency range± 500 ppm
Clock frequency accuracy± 3 ppm
± 1 ppm per year
Jitter tolerancePer BELL CORE GR-253-CORE-1995

Level measurement

Range	5 to –45 dBm
Accuracy	± 2 dB
Resolution	± 0.1 dB
Multimode receiver	
Single mode transmitter	

OPTICAL SPECIFICATIONS FOR OC-48	DSXNominal 0.61 Vp; signal meets
Optical connectors	ANSI T1.102-1993 and ITU-T G.703
1 OC-48 Receive - FC, SC, or ST	LowNominal 0.31 Vp
1 OC-48 High-Power Transmit - FC, SC, or ST	Output impedance
1 OC-48 Low-Power Transmit - FC, SC, or ST	unbalanced to ground
	Jitter tolerancePer TR-TSY-000499
Transmitter	Frequency
Single/multimode fiber compatible	DS344.736 MHz ± 10 ppm
Dual wavelength1310 nm/1550 nm	STS-151.84 MHz ± 3 ppm ± 1 ppm per year
Clock frequency accuracy± 3 ppm	The second secon
High-power TX output+2.0 dBm to -4.3 dBm	INPUT SPECIFICATIONS FOR DS1
Low-power TX output8.0 dBm to -15.0 dBm	Connector typeBantam jack
	Frequency
Receiver	Impedance
Single/multimode fiber compatible	BRIDGE
Dual wavelength1310 nm/1550 nm	TERM
Rx clock frequency± 3 ppm	DSX-MON
Receive level sensitivity8 dBm to -28 dBm	DOX-WON100 0mms ± 3/0
Receiver shutdown6 dBm or higher	Range
INDUT SPECIFICATIONS FOR DS- AND STS 4	BRIDGE+6 to -35.0 dBdsx
INPUT SPECIFICATIONS FOR DS3 AND STS-1 Connector typeWECO 560A jack	TERM+6 to -35.0 dBdsx
	DSX-MON10 to -26.0 dBdsx of resistive loss
Input level	Jitter tolerancePer Bell Pub 62411-1990
HighAccepts nominal 1.2 Vp, 0 ft of cable from High Source	Accuracy
DSXAccepts nominal 0.6 Vp, 450 ft	Receive Level MeasurementFrom 6 dBdsx to
of cable from High Source	-15 dBdsx , accuracy of $\pm 1 \text{ dB}$
LowAccepts nominal 0.3 Vp, 900 ft	From –16 dBdsx to
of cable from High Source	-30 dBdsx , accuracy of $\pm 2 \text{ dB}$
Maximum signal level without errors with 1.7 Vp	From –31 dBdsx to –40 dBdsx, accuracy of ± 3 dB
Minimum signal level without errors with 0.025 Vp	Simplex current measurement± 2% or
Maximum input signal level with 2.5 Vp	± 2 mA to 60 mA
Input impedance	\pm 3% or \pm 3 mA from 61 mA to 175 mA
Jitter toleranceExceeds TR-TSY-000499	Frequency measurement accuracy± 3 ppm
	± 1 ppm/year OUTPUT SPECIFICATIONS FOR DS1
OUTPUT SPECIFICATIONS FOR DS3 AND STS-1	Connector typeBantam jack
Connector typeWECO 560A jack	
7,1	LBO level
Output level	Line build-out of 0, –7.5, –15.0, and –22.5 dB of cable
HighNominal 1.2 Vp; signal meets	loss at 772 Hz
ANSI T1.102-1993 and ITU-T G.703	

when subject to 450 ft of cable loss

LBO tolerance **SOURCES**± 2 dB for –22.5 at 772 kHz Specifications/recommendations usedIEEE 743 \pm 1 dB for 0, -7.5, and -15 at 772 kHzITU-T recommendation G.703 Internal timing \pm 3 ppm \pm 1 ppm per yearAT&T publications CB113, CB119, CB132, CB143 Line codesAMI or B8ZSANSI T1.403-1995 Error insert type.....Logic, BPV, or FrameAT&T publications PUB62508, PUB62411 Pulse shapePer applicable specificationsITU-T recommendation G.824TR-TSY-000499, category 1.2ANSI T1.102-1993 Bellcore GR253-Core-1995Bell Pub 62411-1990

Ordering Information

User Interfa	ce Mod	ul	le
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2000-V3 TestPad 2000 (includes soft carrying case, kickstand, AC adapter/charger,

printer cable)

Application Modules

TB2310-DS1 DS1 Communications Analyzer
TB2310-DS3 DS3/DS1 Communications Analyzer

TB2310-STS1 STS-1/DS3/DS1 Communications Analyzer

TB2310-OC3XX * OC3/3c, STS-1/DS3/DS1 Communications Analyzer

TB2310-OC12XX * OC12/12c, OC3/3c, STS-1/DS3/DS1 Communications Analyzer

TB2310-OC48XX * OC48/48c, OC12/12c, OC3/3c, STS-1/DS3/DS1

Communications Analyzer

TB2310-OC48DXX * OC48/48c, OC12/12c, OC3/3c, STS-1/DS3/DS1

Communications Analyzer with both 1310 nm and 1550 nm laser

Analyzer Options

TB2310-ASP	Advanced stress patterns
TB2310-ATM-OC3	ATM analysis for OC3c
TB2310-ATM-OC12	ATM analysis for OC12c

TB2310-DDS Digital data services (DDS) analysis

TB2310-DUALRX Secondary receiver for DS3 and STS-1 interfaces

TB2310-FT1 Fractional T1
TB2310-GR303 GR-303 analysis

TB2310-ILE Intelligent Line equipment

TB2310-PRI Primary Rate ISDN

^{*} Specify type of optical connector: FC, SC, or ST

TB2310-SIG Signaling

TB2310-TIM VF PCM TIMS
TB2310-VT100 VT100 emulation

Packages

	DS1	DS3	STS1	OC3	OC12	OC48	OC48D	UIM	VT100	Dual Rx
TB2310-P1	X	X	X		9			X	X	X
TB2310-P2	X	X	X	X	S			X	X	X
TB2310-P3	X	X	X	X	Х			X	X	X
TB2310-P4	X							X	X	X
TB2310-P5	Х	X						X	X	X
TB2310-P6	X	X	X	X	X	X		X	X	X
TB2310-P7	Х	X	X	X	X		X	X	X	X

	FT1	TIM	SIG	ASP	ILE	DDS	PRI
TB2310-SW1	X	X	X	X	-		
TB2310-SW2	X	Х	X	X	Х	Х	
TB2310-SW3	X	X	X	X			X
TB2310-SW4	X	X	X	X	X	X	X

Optional Accessories

AC-31705 External Battery Charger

AC-31891 Hanging Strap

BA-014081 Replacement Battery

CC-44605 Carrying Case, Large, Soft

CC-451-58 Carrying Case, Multi-module, Soft

RM-TTC2000 Rack mount for TestPad

Additional Application Modules Available

Optical Modules

2510 10-Gig Field Services Module 2416 SDH Field Services Module

Access Modules

2209 T1/T3 Field Services Module 2230 E1 Data Communications Analyzer 2207 T1/T3 Wireless Field Services Module

Copper Modules

2109 Copper Analyzer Module 2357 DSL Broadband Services Module

Note: Specifications, terms, and conditions are subject to change without notice.

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